## INTEGRATED CIRCUITS



Product data Supersedes data of 2002 Jun 05

2002 Sep 27





### SSTV16857

48 D1

47 D2

46 GND

45 V<sub>CC</sub>

44 D3

43 D4

42 D5

41 D6

40 D7

39 CLK-

38 CLK+

37 V<sub>CC</sub>

36 GND

35 V<sub>REF</sub>

33 D8

32 D9

31 D10

30 D11

29 D12

28 V<sub>CC</sub>

27 GND

26 D13

25 D14

SW00685

34 RESET

#### **FEATURES**

- Stub-series terminated logic for 2.5 V V<sub>DDQ</sub> (SSTL\_2)
- Optimized for DDR (Double Data Rate) SDRAM applications
- Inputs compatible with JESD8–9 SSTL\_2 specifications.
- Flow-through architecture optimizes PCB layout
- ESD classification testing is done to JEDEC Standard JESD22. Protection exceeds 2000 V to HBM per method A114.
- Latch-up testing is done to JEDEC Standard JESD78, which exceeds 100 mA.
- Same form, fit, and function as SSTL16877
- Full DDR 200/266 solution @ 2.5 V when used with PCKV857
- See SSTV16856 for driver/buffer version with mode select.
- Available in TSSOP-48, TVSOP-48 and 56 ball VFBGA packages

#### DESCRIPTION

The SSTV16857 is a 14-bit SSTL\_2 registered driver with differential clock inputs, designed to operate between 2.3 V and 2.7 V.  $V_{DDQ}$  must not exceed  $V_{CC}$ . Inputs are SSTL\_2 type with  $V_{REF}$  normally at 0.5\*V\_{DDQ}. The outputs support class I which can be used for standard stub-series applications or capacitive loads. Master reset (RESET) asynchronously resets all registers to zero.

The SSTV16857 is intended to be incorporated into standard DIMM (Dual In-Line Memory Module) designs defined by JEDEC, such as DDR (Double Data Rate) SDRAM or SDRAM II Memory Modules. Different from traditional SDRAM, DDR SDRAM transfers data on both clock edges (rising and falling), thus doubling the peak bus bandwidth. A DDR DRAM rated at 133 MHz will have a burst rate of 266 MHz. The modules require between 23 and 27 registered control and address lines, so two 14-bit wide devices will be used on each module. The SSTV16857 is intended to be used for SSTL\_2 input and output signals.

The device data inputs consist of differential receivers. One differential input is tied to the input pin while the other is tied to a reference input pad, which is shared by all inputs.

The clock input is fully differential to be compatible with DRAM devices that are installed on the DIMM. However, since the control inputs to the SDRAM change at only half the data rate, the device must only change state on the positive transition of the CLK signal. In order to be able to provide defined outputs from the device even before a stable clock has been supplied, the device must support an asynchronous input pin (reset), which when held to the LOW state will assume that all registers are reset to the LOW state and all outputs drive a LOW signal as well.

#### QUICK REFERENCE DATA

GND = 0 V;  $T_{amb} = 25^{\circ}C$ ;  $t_r = t_f \le 2.5$  ns

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t <sub>PHL</sub> /t <sub>PLH</sub>	Propagation delay; CLK to Qn	$C_L = 30 \text{ pF}; V_{DDQ} = 2.5 \text{ V}$	2.4	ns
Cl	Input capacitance	$V_{CC} = 2.5 V$	2.9	pF

#### **ORDERING INFORMATION**

PACKAGES	TEMPERATURE RANGE	ORDER CODE	DWG NUMBER
48-Pin Plastic TSSOP	0 to +70 °C	SSTV16857DGG	SOT362-1
48-Pin Plastic TSSOP (TVSOP)	0 to +70 °C	SSTV16857DGV	SOT480-1
56-Ball Plastic VFBGA	0 to +70 °C	SSTV16857EV	SOT702-1

#### PIN CONFIGURATION

Q1 1

Q2 2

GND 3

Q3 5

Q5

GND 8

Q6 10

Q7 11

V<sub>DDQ</sub> 12

GND 13

Q8 14

Q9 15

V<sub>DDQ</sub> 16

GND 17

Q10 18

Q11 19

Q12 20

V<sub>DDQ</sub> 21

GND 22

Q13 23

Q14 24

VDDO

Q4 6

V<sub>DDQ</sub>

## SSTV16857

Product data

#### **PIN DESCRIPTION**

PIN NUMBER	SYMBOL	NAME AND FUNCTION
34	RESET	LVCMOS asynchronous master reset (Active LOW)
48, 47, 44, 43, 42, 41, 40, 33, 32, 31, 30, 29, 26, 25	D1 – D14	SSTL_2 data inputs
1, 2, 5, 6, 7, 10, 11, 14, 15, 18, 19, 20, 23, 24	Q1 – Q14	SSTL_2 data outputs
35	$V_{REF}$	SSTL_2 input reference level
3, 8, 13, 17, 22, 27, 36, 46	GND	Ground (0 V)
28, 37, 45	V <sub>CC</sub>	Positive supply voltage
4, 9, 12, 16, 21	V <sub>DDQ</sub>	Output supply voltage
38 39	CLK+ CLK–	Differential clock inputs

#### **FUNCTION TABLE**

	INPUTS				
RESET	CLK	CLK	D	Q	
L	Х	Х	Х	L	
Н	$\downarrow$	$\uparrow$	Н	Н	
Н	$\downarrow$	$\uparrow$	L	L	
Н	L or H	L or H	Х	Q <sub>0</sub>	

H = High voltage level

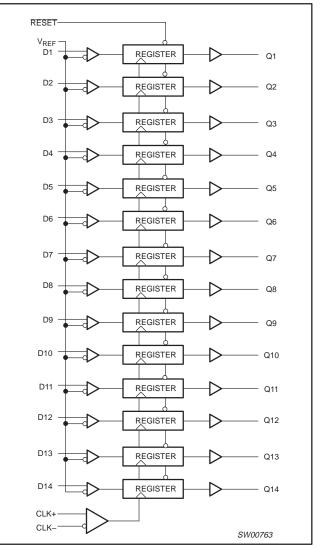
L = High voltage level

 $\downarrow$  = High-to-Low transition

 $\uparrow$  = Low-to-High transition

X = Don't care

#### LOGIC DIAGRAM



### SSTV16857

#### **BALL CONFIGURATION**

	1	2	3	4	5	6
А	Q1	NC	NC	NC	NC	D1
В	GND	Q2	V <sub>CC</sub>	V <sub>CC</sub>	D2	GND
С	Q4	Q3	Q5	D5	D3	D4
D	Vcc	GND	Q6	CLK-	D6	D7
E	V <sub>CC</sub>	Q7			CLK+	V <sub>CC</sub>
F	GND	Q8			V <sub>REF</sub>	GND
G	V <sub>CC</sub>	GND	Q9	RESET	D9	D8
н	Q11	Q12	Q10	D10	D12	D11
J	GND	Q13	V <sub>CC</sub>	V <sub>CC</sub>	D13	GND
К	Q14	NC	NC	NC	NC	D14

#### ABSOLUTE MAXIMUM RATINGS<sup>1</sup>

SYMBOL	PARAMETER	CONDITION	L	UNIT	
STWBUL	FARAMETER	CONDITION		MAX	UNIT
V <sub>CC</sub>	DC supply voltage		-0.5	+4.6	V
I <sub>IK</sub>	DC input diode current	V <sub>1</sub> < 0	—	-50	mA
VI	DC input voltage <sup>3</sup>		-0.5	V <sub>DDQ</sub> + 0.5	V
I <sub>ОК</sub>	DC output diode current	V <sub>O</sub> < 0	—	-50	mA
V <sub>OUT</sub>	DC output voltage <sup>3</sup>		-0.5	V <sub>DDQ</sub> + 0.5	V
	DC output current	$V_{O} = 0$ to $V_{DDQ}$	—	±50	
IOUT	Continuous current <sup>4</sup>	V <sub>CC</sub> , V <sub>DDQ</sub> , or GND	—	±100	mA
T <sub>stg</sub>	Storage temperature range <sup>2</sup>		-65	+150	°C

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction

temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

3.

4. The continuous current at V<sub>CC</sub>, V<sub>DDQ</sub>, or GND should not exceed ±100 mÅ.

### SSTV16857

Product data

#### **RECOMMENDED OPERATING CONDITIONS<sup>1</sup>**

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>CC</sub>	Supply voltage		2.3	2.5	2.7	V
V <sub>DDQ</sub>	Output supply voltage		2.3	2.5	2.7	V
$V_{REF}$	Reference voltage (V <sub>REF</sub> = 0.5 x V <sub>DDQ</sub> )		1.15	1.25	1.35	V
V <sub>TT</sub>	Termination voltage		V <sub>REF</sub> – 40 mV	V <sub>REF</sub>	V <sub>REF</sub> + 40 mV	V
VI	Input voltage		0	—	V <sub>CC</sub>	V
V <sub>IH</sub>	AC HIGH-level input voltage	All inputs	V <sub>REF</sub> + 350 mV	—	—	V
V <sub>IL</sub>	AC LOW-level input voltage	All inputs	-	—	V <sub>REF</sub> – 350 mV	V
VIH	DC HIGH-level input voltage	All inputs	V <sub>REF</sub> + 180 mV	—	V <sub>DDQ</sub> + 0.5 V	V
VIL	DC LOW-level input voltage	All inputs	V <sub>SS</sub> – 0.5 V	—	V <sub>REF</sub> – 180 mV	V
I <sub>OH</sub>	HIGH-level output current		—	—	-20	mA
I <sub>OL</sub>	LOW-level output current		—	—	20	mA
T <sub>amb</sub>	Operating free-air temperature range		0	—	70	°C

NOTE:

1. Unused control inputs must be held HIGH or LOW to prevent them from floating.

#### DC ELECTRICAL CHARACTERISTICS

Over recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

				L	IMITS		
SYMBOL	PARAMETER	TEST CONDI	TEST CONDITIONS		Temp = 0 to +70 °C		
				MIN	TYP <sup>2</sup>	MAX	
V <sub>IK</sub>	I/O supply voltage	$V_{CC} = 2.3 \text{ V}; I_{I} = -18 \text{ mA}$		—	—	-1.2	
		$V_{CC}$ = 2.3 V to 2.7 V; $I_{OH}$ = -100	μA	$V_{CC} - 0.2$	—	—	V
V <sub>OH</sub>	HIGH level output voltage	$V_{CC} = 2.3 \text{ V}; I_{OH} = -16 \text{ mA}$		1.95	—	_	
N N	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}; I_{OL} = 100 \mu\text{A}$		_	—	0.2	V	
V <sub>OL</sub>	LOW level output voltage	V <sub>CC</sub> = 2.3 V; I <sub>OL</sub> = 16 mA		_	—	0.35	V
V <sub>CMR</sub>	CLK, CLK	Common mode range for reliable performance		0.97	—	1.53	V
V <sub>PP</sub>	CLK, CLK	Minimum peak-to-peak input to ensure logic state		360	—	—	mV
		$V_{CC}$ = 2.7 V; $V_{I}$ = 1.7 V or 0.8 V	V = 1.15 V or 1.25 V	—	0.01	±5	
	Data inputs, RESET	$V_{CC}$ = 2.7 V; V <sub>I</sub> = 2.7 V or 0 V	V <sub>REF</sub> = 1.15 V or 1.35 V	—	0.01	±5	μA
l li	CLK, CLK	$V_{CC} = 2.7 \text{ V}; \text{ V}_{\text{I}} = 1.7 \text{ V} \text{ or } 0.8 \text{ V}$		—	0.05	±5	
	ULR, ULR	$V_{CC}$ = 2.7 V; $V_{I}$ = 2.7 V or 0 V	V <sub>REF</sub> = 1.15 V or 1.35 V	_	0.05	±5	μA
	V <sub>REF</sub>	$V_{CC} = 2.7 V$	V <sub>REF</sub> = 1.15 V or 1.35 V	—	0.05	±5	μΑ
	Quiescent supply current	$V_{CC}$ = 2.7 V; $V_{I}$ = 1.7 V or 0.8 V	RESET = GND	_	0.5	10	μA
Icc	CLK and CLK in opposite state <sup>1</sup>	$V_{CC}$ = 2.7 V; $V_{I}$ = 2.7 V or 0 V	$\overline{\text{RESET}} = V_{CC}$	—	10	25	mA

**NOTES:** 1. When CLK and  $\overline{CLK}$  are HIGH, typical  $I_{CC} = 25$  mA. 2. All typical values are at  $V_{CC} = 2.5$  V and  $T_{amb} = 25$  °C (unless otherwise specified).

SSTV16857

#### TIMING REQUIREMENTS

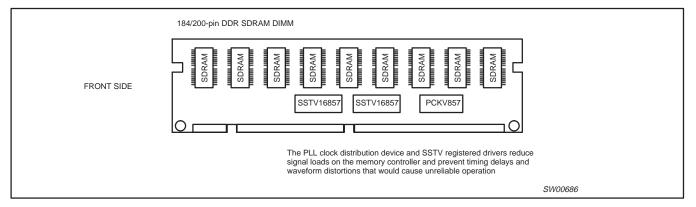
Over recommended operating conditions;  $T_{amb}$  = 0 to +70 °C (unless otherwise noted) (see Figure 1)

				LIMITS		
SYMBOL	PARAMETER	TEST CONDITIONS	V <sub>CC</sub> = 2.5	UNIT		
			MIN	МАХ		
f <sub>clock</sub>	Clock frequency		—	200	MHz	
tw	Pulse duration, CLK, CLK HIGH or LOW		1.0	—	ns	
	Satur time	Data before CLK↑, <u>CLK</u> ↓	0.2	—	20	
t <sub>su</sub>	Setup time RESET HIGH before CLK↑, CLK↓		0.8	—	ns	
t <sub>h</sub>	Hold time		0.75	_	ns	

#### SWITCHING CHARACTERISTICS

Over recommended operating conditions;  $T_{amb} = 0$  to +70 °C;  $V_{DDQ} = 2.3 - 2.7$  V and  $V_{DDQ}$  does not exceed  $V_{CC.}$ Class I,  $V_{REF} = V_{TT} = V_{DDQ} \times 0.5$  and  $C_L = 10$  pF (unless otherwise noted) (see Figure 1)

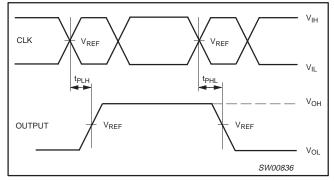
			LIM		
SYMBOL	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 2.5	UNIT	
	· · · /		MIN	MAX	
f <sub>max</sub>	Maximum clock frequency		200	—	MHz
t <sub>PLH</sub> /t <sub>PHL</sub>	CLK and CLK	Q	1.0	2.8	ns
t <sub>PHL</sub>	RESET	Q	2.0	4.0	ns



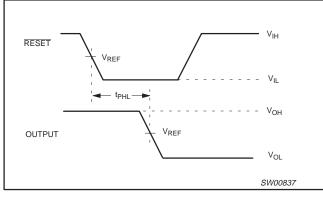
### SSTV16857

#### PARAMETER MEASUREMENT INFORMATION

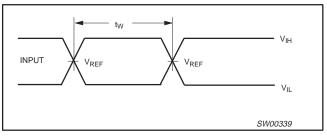
#### **AC WAVEFORMS**



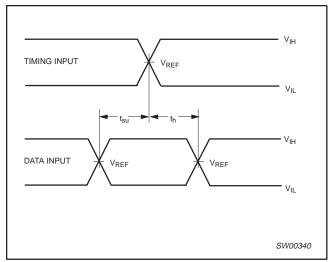
Waveform 1. Propagation delay times



Waveform 2. Propagation delay RESET to output.



Waveform 3. Pulse duration



Waveform 4. Setup and hold times

#### **TEST CIRCUIT**

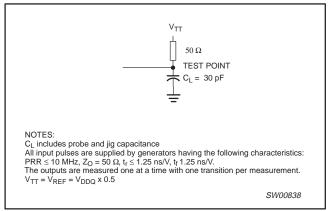
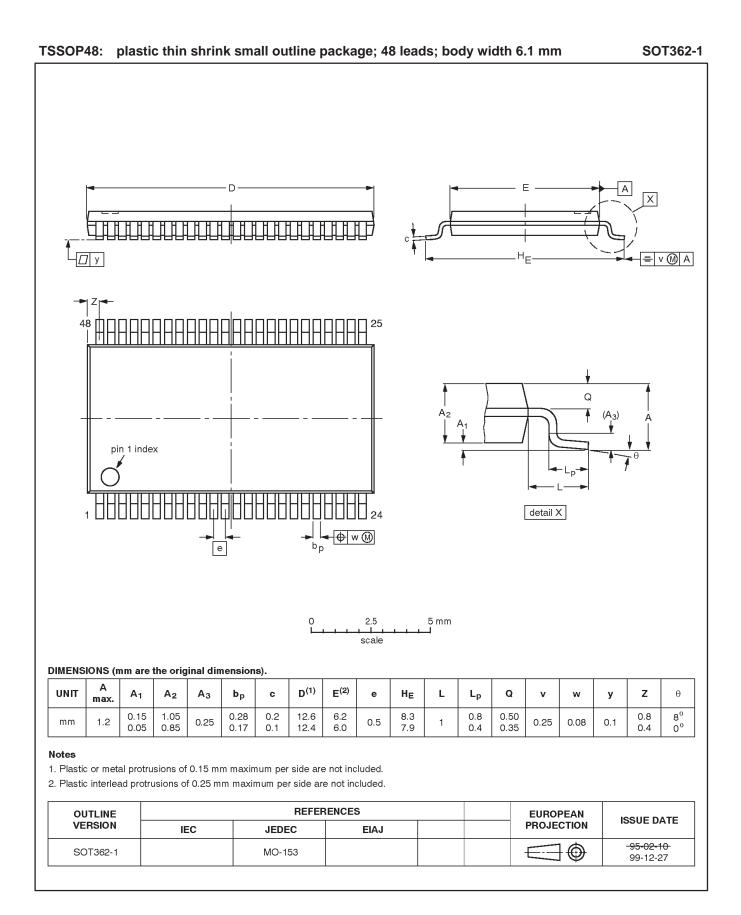


Figure 1. Load circuitry

SSTV16857

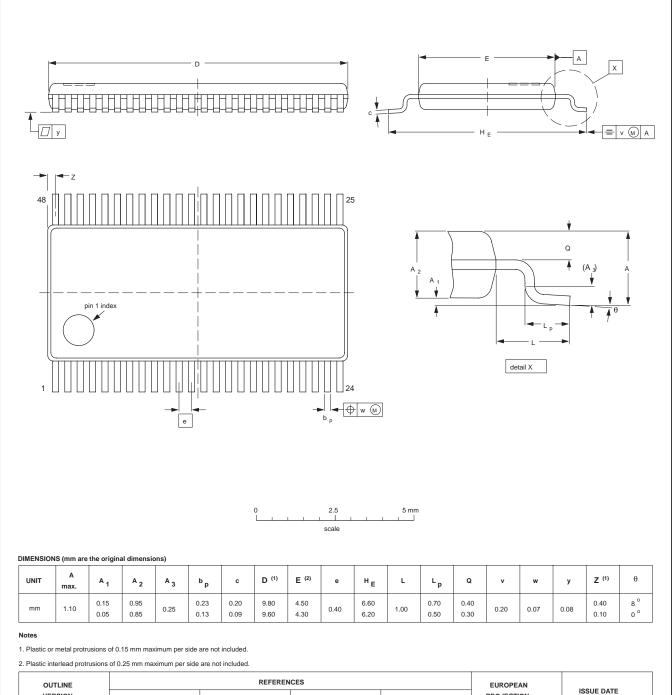


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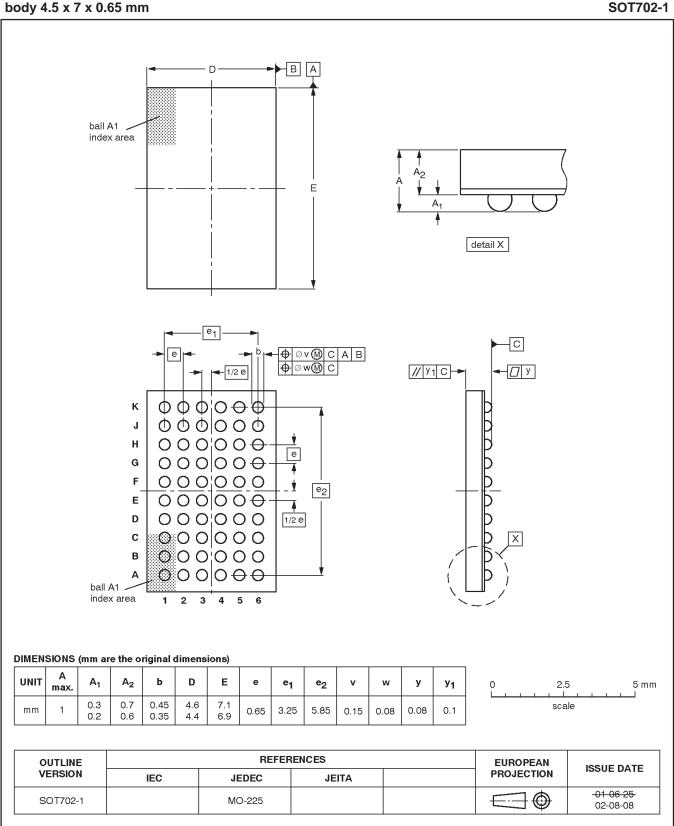
#### TSSOP48: plastic thin shrink small outline package; 48 leads; body width 4.4 mm; lead pitch 0.4 mm



Product data

SOT480-1

SSTV16857



## VFBGA56: plastic very thin fine-pitch ball grid array package; 56 balls; body 4.5 x 7 x 0.65 mm

### SSTV16857

#### **REVISION HISTORY**

Rev	Date	Description
_6	2002 Sep 27	Product data (9397 750 10412); sixth version supersedes Product data fifth version, 2002 Jun 05. Engineering Change Notice: 853 2224 28989 (2002 Sep 26). Modifications: Package type changed from SSTV16857EC to SSTV16857EV.
_5	2002 Jun 05	Product data (9397 750 09942); fifth version.

### SSTV16857

#### Data sheet status

Data sheet status <sup>[1]</sup>	Product status <sup>[2]</sup>	Definitions
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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